

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/710,307	BONALLE ET AL.	
Examiner	Art Unit	
Daniel I. Walsh	2876	

SEAR		
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Subclass	Date	Examiner
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		Subclass Date

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST Search attached	9/30/2006	DW		
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